



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Peter de Groot et al. Art Unit : 2877
Serial No. : 10/795,808 Examiner : Unknown
Filed : March 8, 2004
Title : PROFILING COMPLEX SURFACE STRUCTURES USING SCANNING
INTERFEROMETRY

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

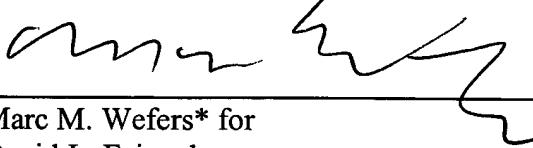
INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050, referencing Attorney Docket No. 09712-341001.

Respectfully submitted,

Date: 8/26/01



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*See attached document certifying that Marc M. Wefers has limited recognition to practice before the U.S. Patent and Trademark Office under 37 C.F.R. § 10.9(b).

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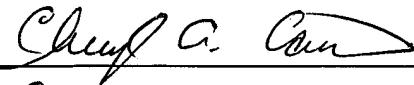
CERTIFICATE OF MAILING BY FIRST CLASS MAIL

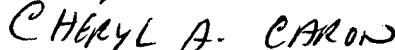
I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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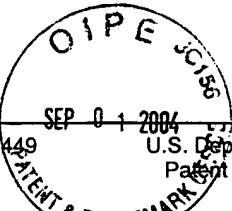
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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 09712-341001	Application No. 10/795,808
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Peter de Groot et al.	
		Filing Date March 8, 2004	Group Art Unit 2877

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,398,113	03/14/1995	de Groot	356	360	
	AB	5,587,792	12/24/1996	Nishizawa et al.	355	356	
	AC	5,900,633	05/04/1999	Solomon et al.	250	339.08	
	AD	6,242,739	06/05/2001	Cherkassky	250	339.11	
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL	0 929 094 A2	07/14/1999	EPO	H01L	21/00		
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
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